## MTMC8E2A0LBF

### **Dual N-channel MOSFET**

For lithium-ion secondary battery protection circuit

#### ■ Features

- Low drain-source ON resistance:RDS(on)typ. = 15 m $\Omega$  (VGS = 4.5 V)
- · Built-in gate resistor
- Halogen-free / RoHS compliant
   (EU RoHS / UL-94 V-0 / MSL:Level 1 compliant)
- Marking Symbol: 4B

#### ■ Packaging

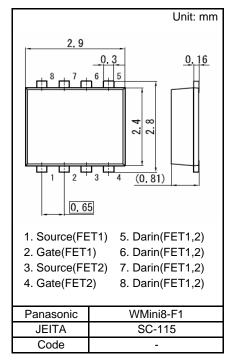
MTMC8E2A0LBF Embossed type (Thermo-compression sealing): 3 000 pcs / reel (standard)

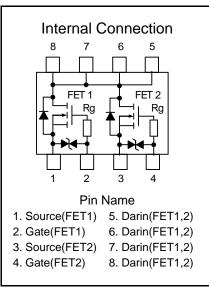
#### ■ Absolute Maximum Ratings Ta = 25 °C

Parameter		Symbol	Rating	Unit	
	Drain-source Voltage	VDS	20	V	
	Gate-source Voltage	VGS	±12	V	
	Drain Current	ID	7.0	Α	
	Peak Drain Current	IDp	42	Α	
Overall	Total Power Dissipation	PD1 *1	1.0	W	
		PD2 *1,*2	1.2		
		PD3 *3	0.4		
	Channel Temperature Range	Tch	150	°C	
	Storage Temperature	Tstg	-55 to +150	°C	
		Tstg	-55 to +150	°C	

Note: \*1 Glass epoxy board: 25.4 mm  $\times$  25.4 mm  $\times$  0.8 mm Copper foil of the drain portion should have a area of 300 mm $^2$  or more PD absolute maximum rating Non-heat sink: 400 mW

- \*2 t = 10 s
- \*3 Non-heat sink





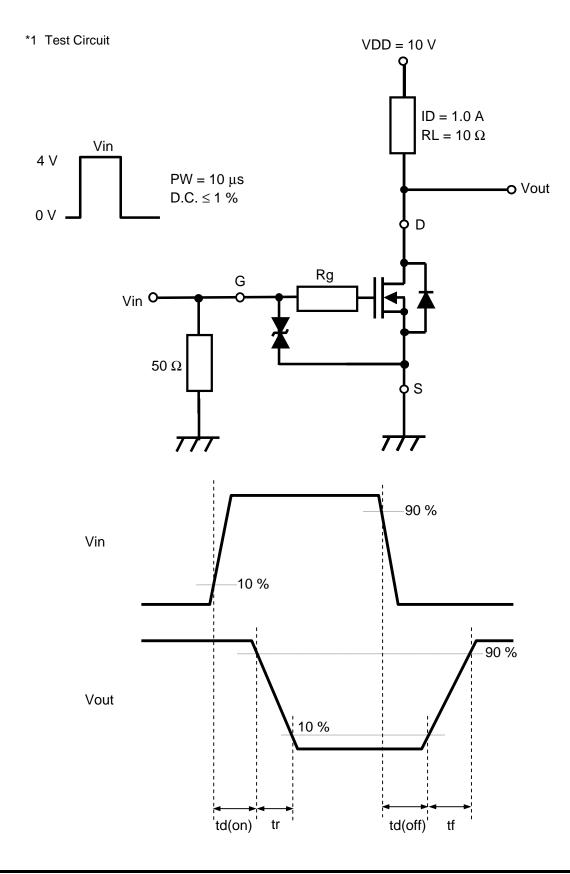
Resistance	DQ	1	kO	
Value	ixy	'	KS2	

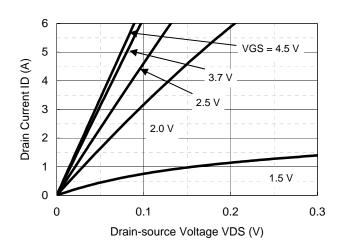
# ■ Electrical Characteristics Ta = 25 °C ± 3 °C FET1,FET2

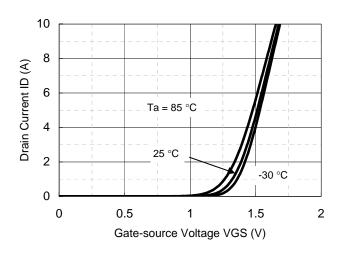
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Drain-source Breakdown Voltage	VDSS	ID = 1.0 mA, VGS = 0 V	20			V
Zero Gate Voltage Drain Current	IDSS	VDS = 20 V, VGS = 0 V			1.0	μΑ
Gate-source Leakage Current	IGSS	VGS = ±8.0 V, VDS = 0 V			±10	μΑ
Gate-source Threshold Voltage	Vth	ID = 1.0 mA, VDS = 10 V	0.40	0.85	1.30	V
	RDS(on)1	ID = 2.0 A, VGS = 4.5 V		15	21	mΩ
Drain-source On-state Resistance	RDS(on)2	ID = 2.0 A, VGS = 3.7 V		18	25	
	RDS(on)3	ID = 2.0 A, VGS = 2.5 V		22	33	
Forward transfer admittance	Yfs	ID = 1.0 A, VDS = -10 V	3.0			S
Input Capacitance	Ciss			1 450		pF
Output Capacitance	Coss	VDS = 10 V, VGS = 0 V, f = 1 MHz		100		
Reverse Transfer Capacitance	Crss	7		90		1
Turn-on Delay Time *1	td(on)	VDD = 10 V, VGS = 0 to 4 V,		0.33		μs
Rise Time *1	tr	ID = 1.0 A		0.70		
Turn-off Delay Time *1	td(off)	VDD = 10 V, VGS = 4 to 0 V,		4.0		0
Fall Time *1	tf	ID = 1.0 A		2.0		μs

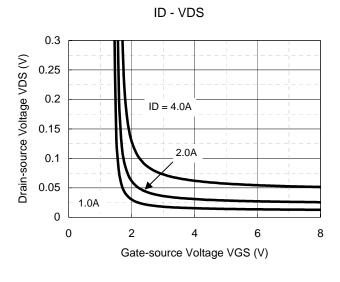
Note: Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 Measuring methods for transistors.

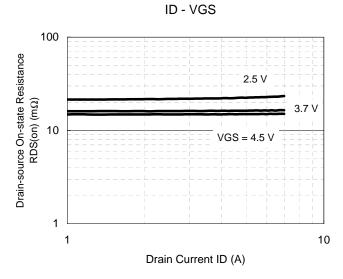
<sup>\*1</sup> See Test Circuit.





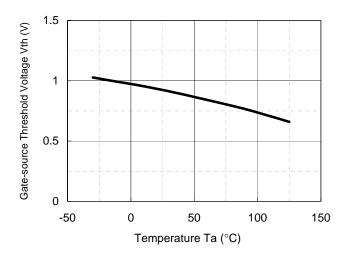


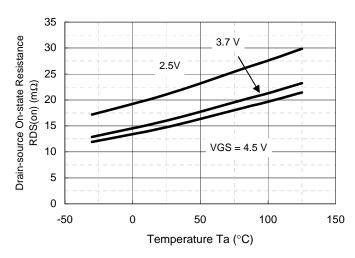


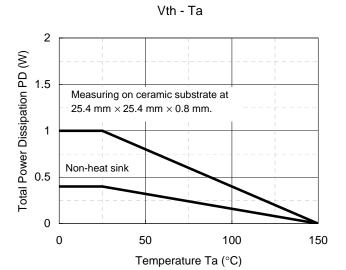


VDS - VGS

RDS(on) - ID

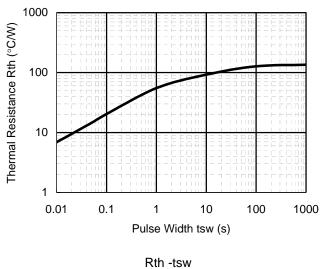


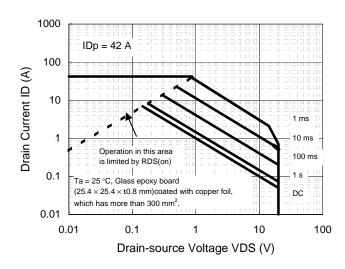






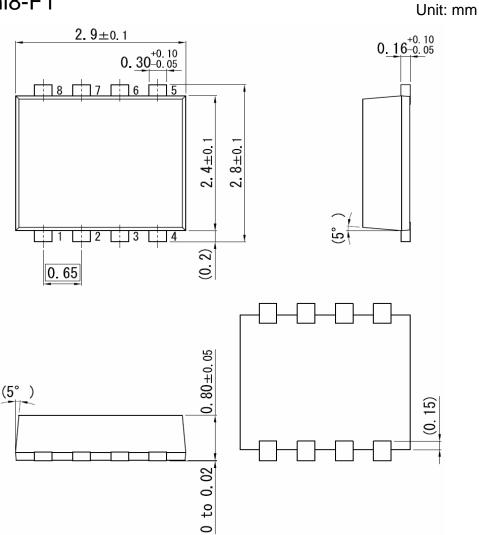




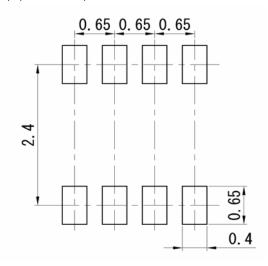


Safe Operating Area

## WMini8-F1



### ■ Land Pattern (Reference) (Unit: mm)



Ver. FED

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